Search Notes				

 Application/Control No.	Applicant(s)/Patent under Reexamination
10/706,605	TSANG ET AL.
Examiner	Art Unit
Tan V. Mai	2193

SEARCHED				
Class	Subclass	Date	Examiner	
708	446	2/12/2007	'MAI	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
Inventor(s) search Double Patent Check Data Bases Search (see search history printout(s))	2/12/2007	MAI	